

#### **QUADRUPLE 3-STATE BUFFERS**

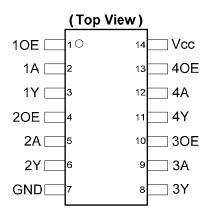
### Description

The 74LVC126A provides four independent buffers with three state outputs. Each output is independently controlled by an associated output enable pin (OE) which places the device in the high impedance state when driven low. The device is designed for operation with a power supply range of 1.65V to 5.5V. The inputs are tolerant to 5.5V allowing this device to be used in a mixed voltage environment. The device is fully specified for partial power down applications using IOFF. The IOFF circuitry disables the output preventing damaging current backflow when the device is powered down.

### **Features**

- Supply Voltage Range from 1.65V to 5.5V
- Sinks 24mA at V<sub>CC</sub> = 3.3V
- CMOS low power consumption
- IOFF Supports Partial-Power-Down Mode Operation
- Inputs or outputs accept up to 5.5V
- Inputs can be driven by 3.3V or 5.5V allowing for voltage translation applications.
- ESD Protection Exceeds JESD 22
  - 200-V Machine Model (A115-A)
  - 2000-V Human Body Model (A114-A)
  - Exceeds 1000-V Charged Device Model (C101C)
- Latch-Up Exceeds 250mA per JESD 78, Class II
- Range of Package Options SO-14 and TSSOP-14
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

### **Pin Assignments**



SO-14 / TSSOP-14

## **Applications**

- Voltage Level Shifting
- General Purpose Logic
- Power Down Signal Isolation
- Wide array of products such as:
  - PCs, networking, notebooks, ultrabooks, netbooks
  - Computer peripherals, hard drives, CD/DVD ROM
  - TV, DVD, DVR, set top box

Notes:

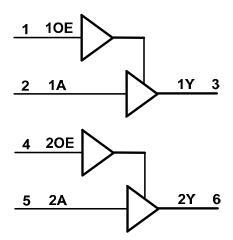
- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

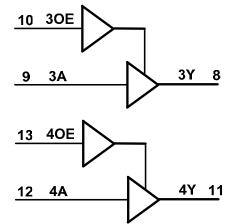


## **Pin Descriptions**

Pin Number	Pin Name	Description
1	10E	Data Enable Input (active high)
2	1A	Data Input
3	1Y	Data Output
4	20E	Data Enable Input (active high)
5	2A	Data Input
6	2Y	Data Output
7	GND	Ground
8	3Y	Data Output
9	3A	Data Input
10	30E	Data Enable Input (active high)
11	4Y	Data Output
12	4A	Data Input
13	40E	Data Enable Input (active high)
14	V <sub>CC</sub>	Supply Voltage

## **Logic Diagram**





# **Function Table**

Inp	Output	
OE	Α	Υ
Н	Н	Н
Н	L	L
L	Х	Z



## Absolute Maximum Ratings (Note 4) (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Symbol	Description	Rating	Unit
ESD HBM	Human Body Model ESD Protection	2	KV
ESD CDM	Charged Device Model ESD Protection	1	KV
ESD MM	Machine Model ESD Protection	200	V
V <sub>CC</sub>	Supply Voltage Range	-0.5 to +6.5	V
Vı	Input Voltage Range	-0.5 to +6.5	V
Vo	Voltage applied to output in high impedance or I <sub>OFF</sub> state	-0.5 to +6.5	V
Vo	Voltage applied to output in high or low state	-0.3 to V <sub>CC</sub> +0.5	V
lıĸ	Input Clamp Current V <sub>I</sub> <0	-50	mA
I <sub>OK</sub>	Output Clamp Current V <sub>O</sub> <0	-50	mA
Io	Continuous output current	±50	mA
I <sub>CC</sub> ,, I <sub>GND</sub>	Continuous current through V <sub>CC</sub> or GND	±100	mA
TJ	Operating Junction Temperature	-40 to +150	°C
T <sub>STG</sub>	Storage Temperature	-65 to +150	°C
P <sub>TOT</sub>	Total Power Dissipation	500	mW

Note: 4. Stresses beyond the absolute maximum may result in immediate failure or reduced reliability. These are stress values and device operation should be within recommend values.

# Recommended Operating Conditions (Note 5) (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Symbol	Parameter	Conditions	Min	Max	Unit	
Vcc	Supply Voltage		1.65	5.50	V	
$V_{I}$	Input Voltage		0	5.5	V	
	Output Voltage	Active Mode	0	V <sub>CC</sub>	V	
Vo		V <sub>CC</sub> = 0V; Power Down Mode	0	5.5	V	
A+/A\/		V <sub>CC</sub> = 1.65V to 2.7V		20	0.7	
Δt/ΔV	Input transition rise or fall rate	V <sub>CC</sub> = 2.7V to 3.6V		10	ns/V	
T <sub>A</sub>	Operating free-air temperature		-40	+125	°C	

Note: 5. Unused inputs should be held at V<sub>CC</sub> or Ground.



# **Electrical Characteristics** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Cumbal	Dovernator	Took Conditions	V	$T_A = -40^{\circ}C$	C to +85°C	$T_A = -40$ °C	to +125°C	l lm!4
Symbol	Parameter	Test Conditions	V <sub>cc</sub>	Min	Max	Min	Max	Unit
			1.65V to 1.95V	0.65 X V <sub>CC</sub>		0.65 X V <sub>CC</sub>		
$V_{IH}$	High-level Input Voltage		2.3V to 2.7V	1.7		1.6		V
	voltage		2.7V to 3.6V	2.0		2.0		
			1.65V to 1.95V		0.35 X V <sub>CC</sub>		0.35 X V <sub>CC</sub>	
$V_{IL}$	Low-level input voltage		2.3V to 2.7V		0.7		0.7	V
	voltage		2.7V to 3.6V		0.8		0.8	
		I <sub>OH</sub> = -100μA	1.65V to 3.6V	V <sub>CC</sub> - 0.2		V <sub>CC</sub> - 0.3		
		I <sub>OH</sub> = -4mA	1.65V	1.2				
	High Level	I <sub>OH</sub> = -8mA	2.3V	1.9				
Vон	Output Voltage	10 1	2.7V	2.2		2.05		- V -
		I <sub>OH</sub> = -12mA	3.0V	2.3		2.1		
		I <sub>OH</sub> = -24mA	3.0V	2.2		2.0		
		I <sub>OH</sub> = 100μA	1.65V to 3.6V		0.2		0.3	
		I <sub>OH</sub> = 4mA	1.65V		0.45		0.6	
	High-level Output	I <sub>OH</sub> = 8mA	2.3V		0.70		0.85	V
$V_{OL}$	Voltage	1. 40 4	2.7V		0.40		0.6	V
		I <sub>OH</sub> = 12mA	3.0V		0.55		0.6	
		I <sub>OH</sub> =-24mA	3.0V		0.55		0.6	
lı	Input Current	V <sub>I</sub> =GND to 5.5V	3.6V		± 5		± 20	μΑ
I <sub>OZ</sub>	Z State Leakage Current	V <sub>O</sub> = GND or 5.5V	3.6V		± 10		± 20	μΑ
I <sub>OFF</sub>	Power Down Leakage Current	$V_I$ or $V_O = 0V$ to 3.6V	0		10		20	μΑ
I <sub>CC</sub>	Supply Current	V <sub>I</sub> = GND or V <sub>CC</sub> I <sub>O</sub> =0	3.6V		10		40	μΑ
ΔI <sub>CC</sub>	Additional Supply Current	One input at V <sub>CC</sub> –0.6V Other	2.7V to 3.6V		500		5000	μΑ



# **Switching Characteristics**

	From	То	Test Conditions		T <sub>A</sub> = +25°	С	-40°C t	o +85°C	-40°C to	+125°C	
Parameter	(Input)	(Output)	See Figure 1	Min	Тур	Max	Min	Max	Min	Max	Unit
			Vcc = 1.8V ± 0.15V	1.0	4.2	9.3	1.0	9.8	1.0	11.3	
t <sub>pd</sub>	Α	Y	Vcc = 2.5V ± 0.2V	1.0	2.7	6.7	1.0	7.2	1.0	9.3	ns
			Vcc = 2.7V	1.0	2.9	5.0	1.0	5.2	1.0	6.5	
			Vcc = 3.3V ± 0.3V	1.0	2.5	4.5	1.0	4.7	1.0	6.0	
		OE Y	Vcc = 1.8V ± 0.15V	1.0	4.8	9.5	1.0	10	1.0	11.5	
t <sub>en</sub>	OE		Vcc = 2.5V ± 0.2V	1.0	2.1	7.8	1.0	8.3	1.0	10.4	ns
			Vcc = 2.7V	1.0	2.3	6.1	1.0	6.3	1.0	8.0	
			Vcc = 3.3V ± 0.3V	1.0	2.5	5.5	1.0	5.7	1.0	7.5	
			Vcc = 1.8 V ± 0.15V	1.0	4.4	12.1	1.0	12.5	1.0	14.1	
t <sub>dis</sub>	OE	Y	Vcc = 2.5V ± 0.2V	1.0	2.7	8.2	1.0	8.7	1.0	10.8	ns
ale			Vcc = 2.7V	1.0	2.7	6.5	1.0	6.7	1.0	8.5	
			Vcc = 3.3V ± 0.3V	1.0	2.3	5.8	1.0	6.0	1.0	7.5	
t <sub>SK(0)</sub>			Vcc = 3.3V ± 0.3V			1.0		1.0		1.5	ns

# Operating Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

	Parameter	Test Conditions	V <sub>CC</sub> = 1.8V Typ	V <sub>CC</sub> = 2.5V Typ	V <sub>CC</sub> = 3.3V Typ	Unit
$C_{pd}$	Power dissipation capacitance per gate	f = 10 MHz	7.3	11.2	14.9	pF
Cı	Input Capacitance	$V_i = V_{CC} - or$ GND	4	4	4	pF

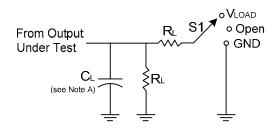
# **Package Characteristics**

Symbol	Parameter	Test Conditions	Vcc	Min	Тур	Max	Unit
0	Thermal Resistance	SO-14	(Nata C)		TBD		°C/W
$\theta_{JA}$	Junction-to-Ambient	TSSOP-14	(Note 6)		159		C/vv
0	Thermal Resistance	SO-14	(Note 6)		TBD		°C/W
$\theta_{ m JC}$	Junction-to-Case	TSSOP-14	(Note 6)		25		C/VV

Note: 6. Test condition for SO-14 and TSSOP-14: Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

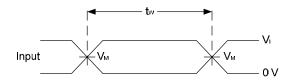


### **Parameter Measuement Information**

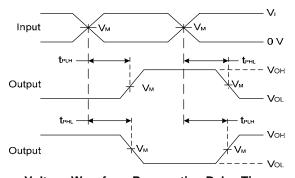


TEST	<b>S</b> 1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	VLOAD
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

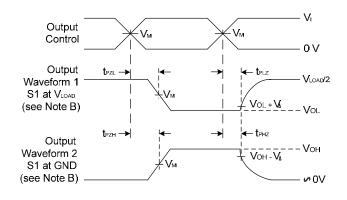
V	Inputs		v	V. V		В	V A	
V <sub>CC</sub>	$V_{I}$	t <sub>r</sub> /t <sub>f</sub>	V M	V <sub>M</sub> V <sub>LOAD</sub>		$R_L$	<b>V</b> Δ	
1.8V±0.15V	Vcc	≤2ns	V <sub>CC</sub> /2	2 x V <sub>CC</sub>	30pF	1ΚΩ	0.15V	
2.5V±0.2V	V <sub>CC</sub>	≤2ns	V <sub>CC</sub> /2	2 x V <sub>CC</sub>	30pF	500Ω	0.15V	
2.7V	2.7V	≤2.5ns	1.5V	6V	50pF	500Ω	0.3V	
3.3V±0.3V	2.7V	≤2.5ns	1.5V	6V	50pF	500Ω	0.3V	



#### **Voltage Waveform Pulse Duration**



**Voltage Waveform Propagation Delay Times Inverting and Non Inverting Outputs** 



**Voltage Waveform Enable and Disable Times** Low and High Level Enabling

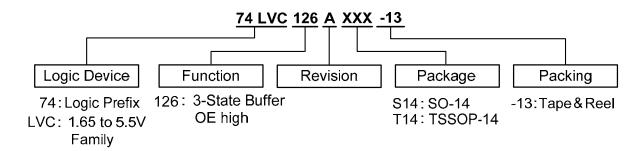
A. Includes test lead and test apparatus capacitance. Notes:

- B. All pulses are supplied at pulse repetition rate ≤ 10 MHz.
- C. Inputs are measured separately one transition per measurement.
- D.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis.}$
- E.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{EN0}$
- F. t<sub>PLH</sub> and t<sub>PHL</sub> are the same as t<sub>PD</sub>.

Figure 1. Load Circuit and Voltage Waveforms



## **Ordering Information**

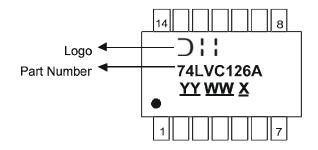


	Davies	Package	Packaging	13" Tape	ind Reel	
	Device	Code	(Note 5)	Quantity	Part Number Suffix	
Pb	74LVC126AS14-13	S14	SO-14	2500/Tape & Reel	-13	
Pb	74LVC126AT14-13	T14	TSSOP-14	2500/Tape & Reel	-13	

Notes: 7. The taping orientation and tape details can be found at http://www.diodes.com/datasheets/ap02007.pdf

## **Marking Information**

### (1) SO-14, TSSOP-14



YY: Year: 08, 09,10~ WW: Week: 01~52; 52 represents 52 and 53 week

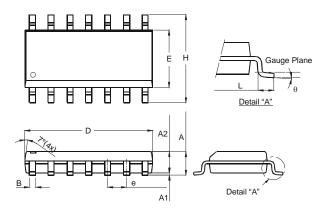
X : Internal Code

Part Number	Package
74LVC126AS14	SO-14
74LVC126AT14	TSSOP-14



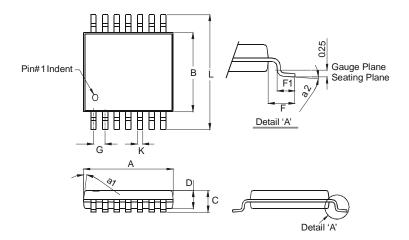
# Package Outline Dimensions (All dimensions in mm.)

## Package Type: SO-14



SO-14		
Dim	Min	Max
Α	1.47	1.73
A1	0.10	0.25
A2	1.45 Typ	
В	0.33	0.51
D	8.53	8.74
Е	3.80	3.99
е	1.27 Typ	
Н	5.80	6.20
L	0.38	1.27
θ	0°	8°
All Dimensions in mm		

## Package Type: TSSOP-14

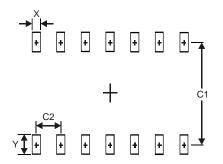


TSSOP-14			
Dim	Min	Max	
a1	7° (4X)		
a2	0°	8°	
Α	4.9	5.10	
В	4.30	4.50	
С	_	1.2	
D	0.8	1.05	
F	1.00 Typ		
F1	0.45	0.75	
G	0.65 Typ		
K	0.19	0.30	
L	6.40 Typ		
All Dimensions in mm			



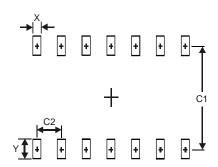
## **Suggested Pad Layout**

### Package Type: SO-14



<b>Dimensions</b>	Value (in mm)
Х	0.60
Y	1.50
C1	5.4
C2	1 27

### Package Type: TSSOP-14



Dimensions	Value (in mm)	
X	0.45	
Υ	1.45	
C1	5.9	
C2	0.65	



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